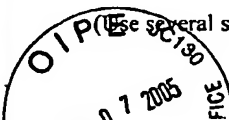


<p>FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE</p> <p>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</p> <p>(Use several sheets if necessary)</p> 	<p>ATTY DOCKET NO. DN2003182</p>	<p>SERIAL NO. 10/717,780</p> <p>Confirmation No. 8395</p>
	<p>APPLICANT (S) Jean Joseph Collette, et al</p>	
	<p>FILING DATE November 20, 2003</p>	<p>GROUP 3617</p>

U.S. PATENT DOCUMENTS

[illegible]

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Examiner Initial		Document Number	Date	Country	Class	Sub-Class	Translation YES	NO
	→	100809290	March 31, 1998	Japan	B30C	33/02		X
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OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

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EXAMINER	Maki	DATE CONSIDERED: 6-18-05

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	APPLICANT (S) Jean Joseph Collette et al.	
	FILING DATE	GROUP

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Jm	4 7 9 4 9 6 5	Jan. 3, 1989	Lagnier	152	209 R	
Jm	5 3 5 0 0 0 1	Sep. 27, 1994	Beckmann et al.	152	209 R	
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EXAMINER	Maki	DATE CONSIDERED: 6-18-05

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